

Automotive Chip Choke®

EMI Suppression for CAN-Bus Networks

2-Line Common Mode Chokes

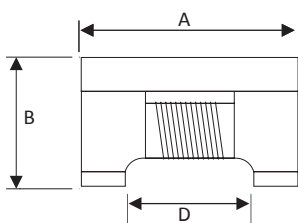


- Meets AEC-Q200 Requirements
- Suppression of common mode noise without attenuating the signal
- Magnetically shielded versions for lower Rdc and higher current
- Supports CAN-Bus, A2B and other IVN high speed differential signal lines (LVDS)

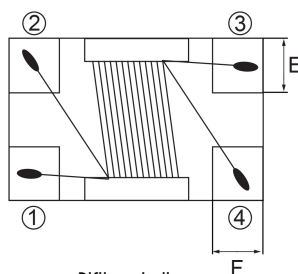
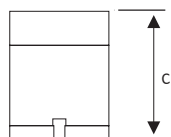
Electrical Specifications @ 25°C

Part Number	Common Mode Impedance (10MHZ)		Inductance (uH)	Standard Tolerance	RDC (Ω Max)	Leakage Inductance (nH) Max	IDC (A) Max	Isolation Resistance (MΩ) Min	Rated Voltage (V) Max
	Min	Typ							
PE-1210ACCXXXSTS			Operating Temperature Range -55°C to +155°C						
PE-1210ACC110STS	300	550	11	+50/-30%	0.4	50	0.3	10	80
PE-1210ACC220STS	500	1100	22	+50/-30%	0.5	70	0.25	10	80
PE-1210ACC510STS	1000	2600	51	+50/-30%	0.7	130	0.2	10	80
PE-1210ACC101STS	2200	5100	100	+50/-30%	1.5	180	0.15	10	80
PE-1812ACCXXXSTS			Operating Temperature Range -40°C to +125°C						
PE-1812ACC110STS	300	600	11	+50/-30%	0.5	45	0.36	10	50
PE-1812ACC220STS	600	1200	22	+50/-30%	0.6	50	0.31	10	50
PE-1812ACC510STS	1500	3500	51	+50/-30%	1	150	0.23	10	50
PE-1812ACC101STS	3000	7500	100	+50/-30%	2	200	0.2	10	50

Mechanical

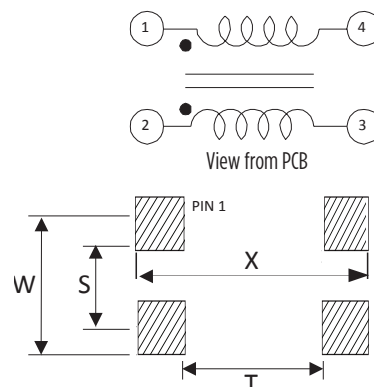


All Units in mm



Bifilar winding
(representation only)

Schematic



Component Dimensions (mm)

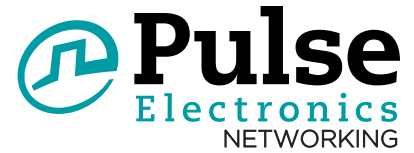
SODLER PAD(mm)

Series	A	B	C	D	e	f	X	T	W	S
1210 ACC	32+/-0.20	25+/-0.20	25 MAX	32+/-0.20	32+/-0.20	32+/-0.20	4.40	2.40	3.00	1.20
1812 ACC	4.5+/-0.20	32+/-0.20	3.0 MAX	32+/-0.20	0.65+/-0.15	0.70+/-0.15	5.90	3.20	3.40	1.60

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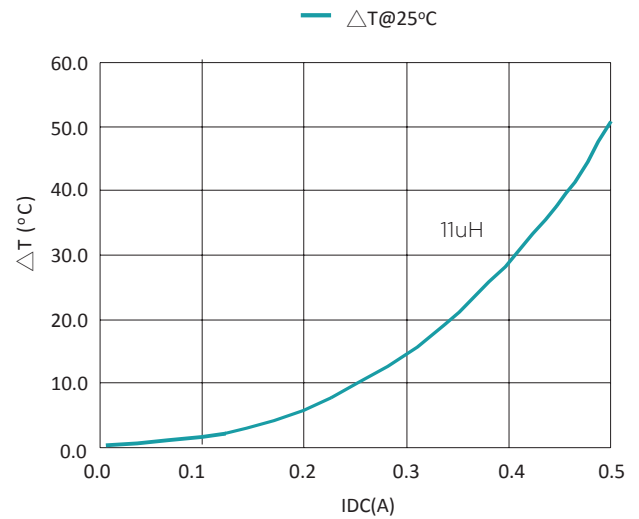
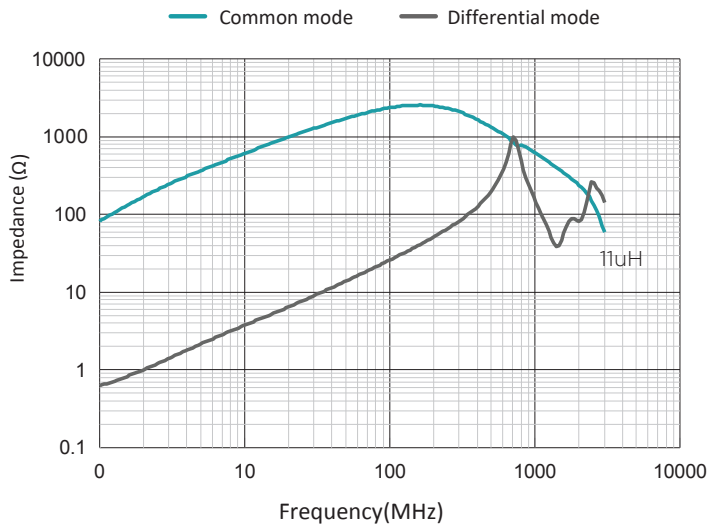
2-Line Common Mode Chokes



Impedance vs Frequency

Temp vs DC Current

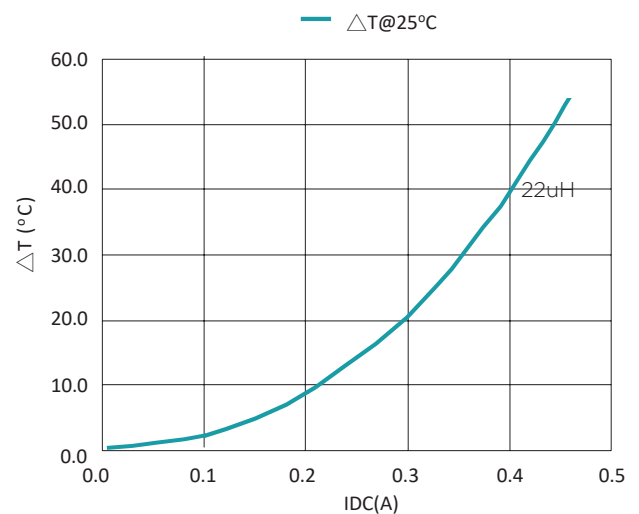
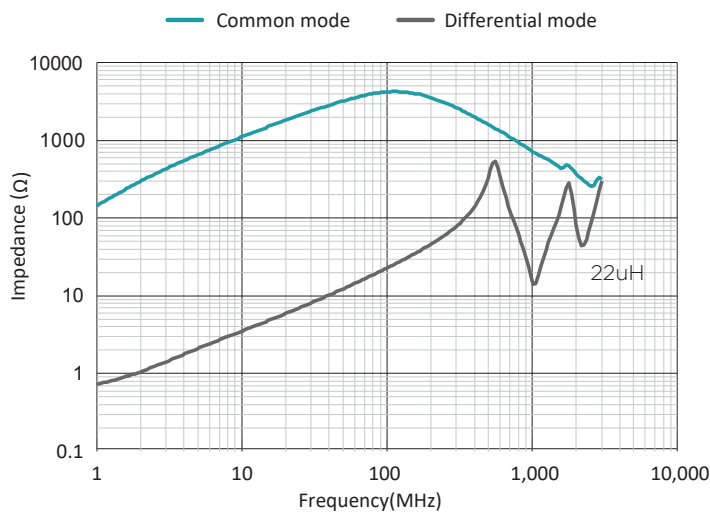
PE-1210ACC110STS



Impedance vs Frequency

Temp vs DC Current

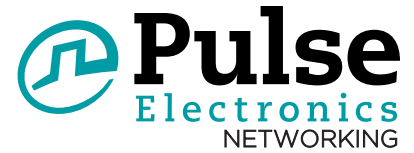
PE-1210ACC220STS



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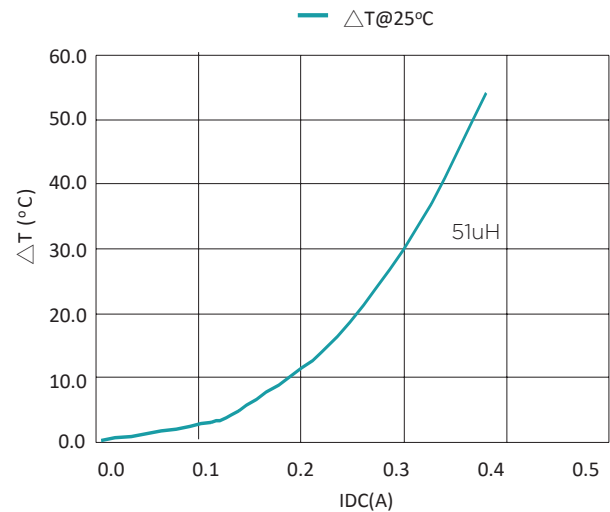
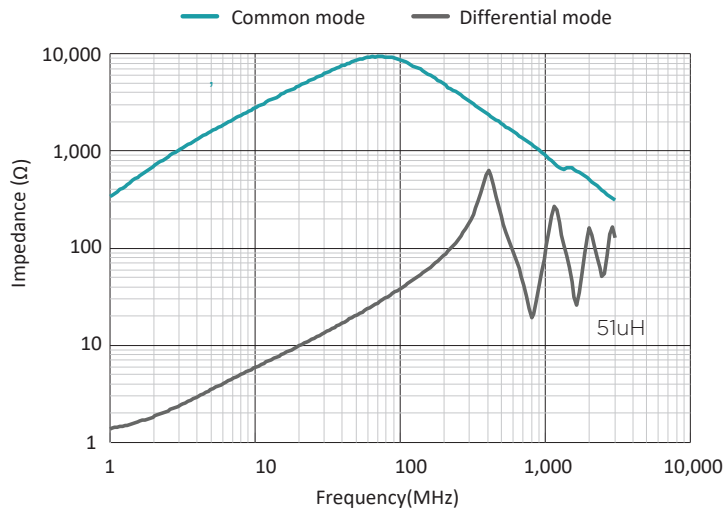
2-Line Common Mode Chokes



Impedance vs Frequency

Temp vs DC Current

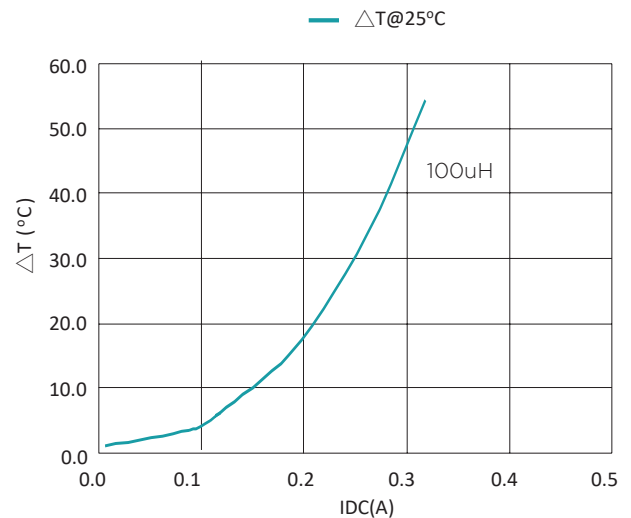
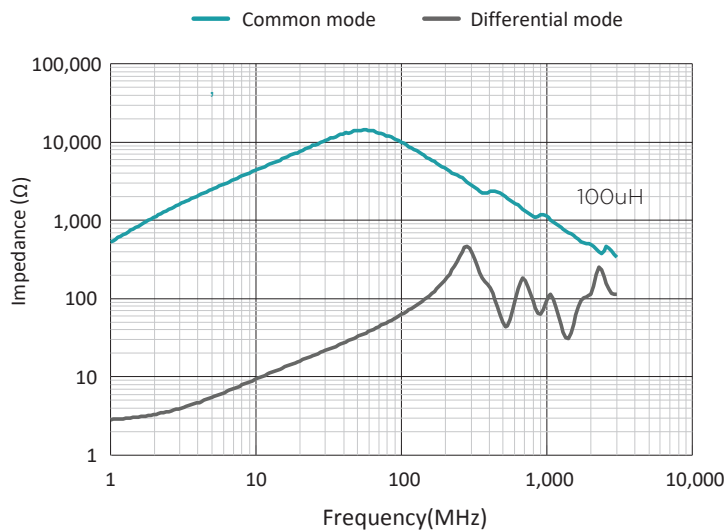
PE-1210ACC510STS



Impedance vs Frequency

Temp vs DC Current

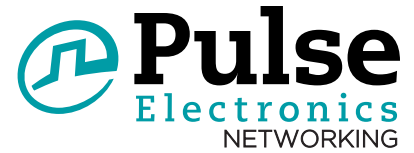
PE-1210ACC101STS



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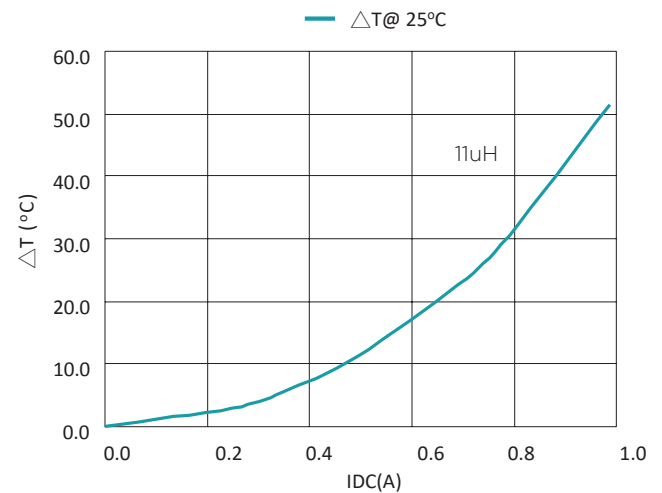
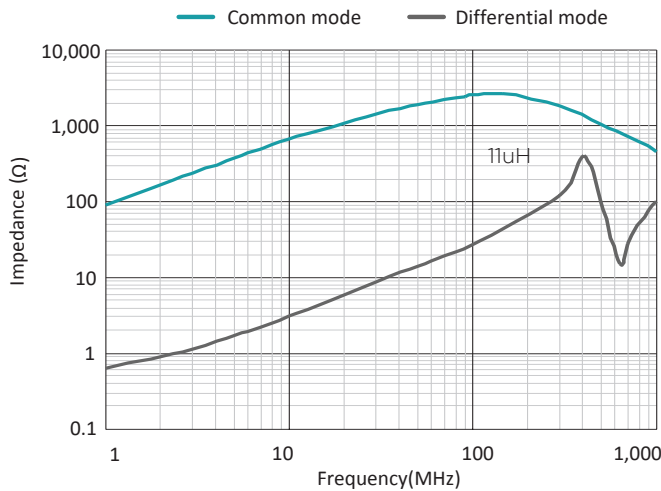
2-Line Common Mode Chokes



Impedance vs Frequency

Temp vs DC Current

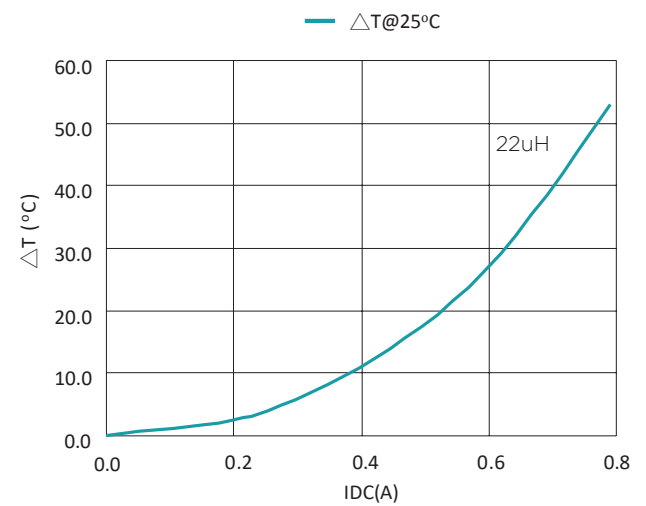
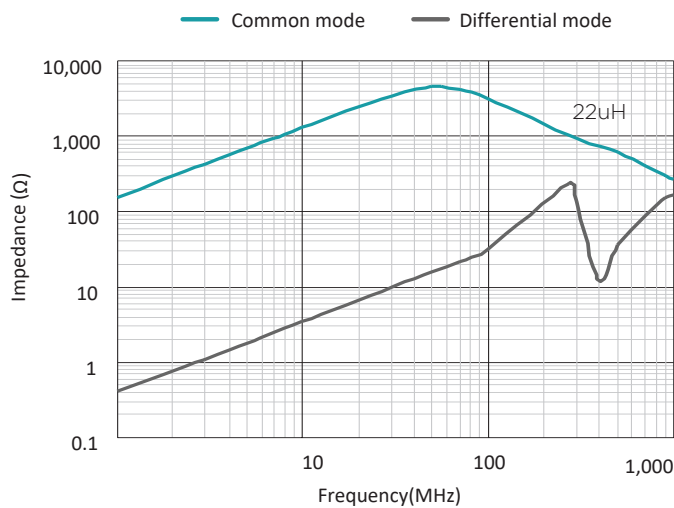
PE-1812ACC110STS



Impedance vs Frequency

Temp vs DC Current

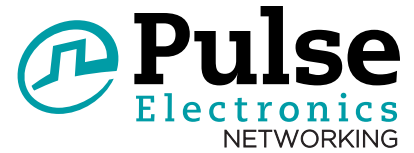
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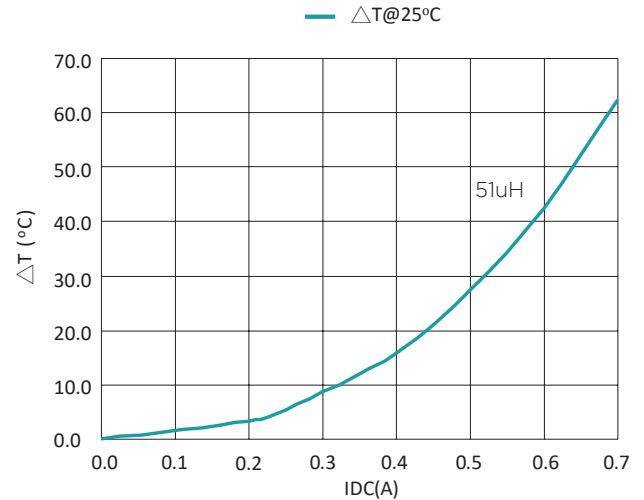
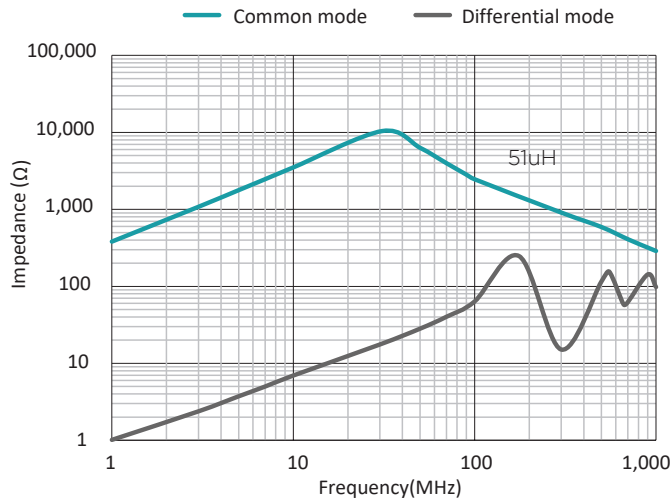
2-Line Common Mode Chokes



Impedance vs Frequency

Temp vs DC Current

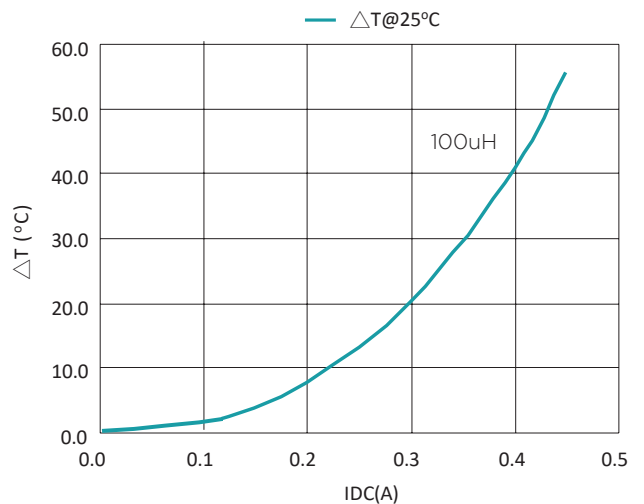
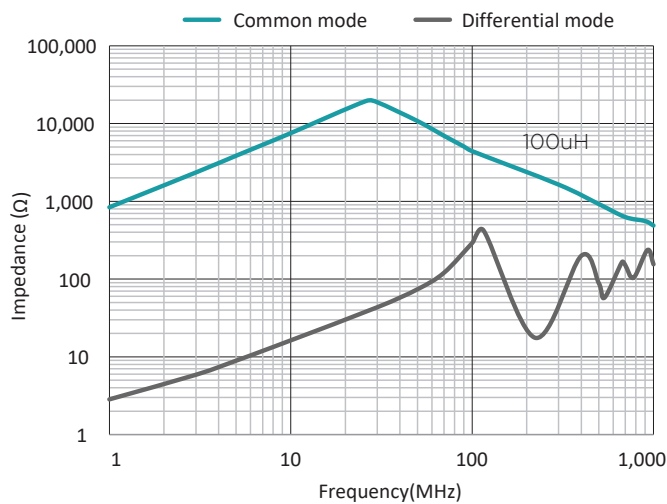
PE-1812ACC510STS



Impedance vs Frequency

Temp vs DC Current

PE-1812ACC101STS



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Reliability Test

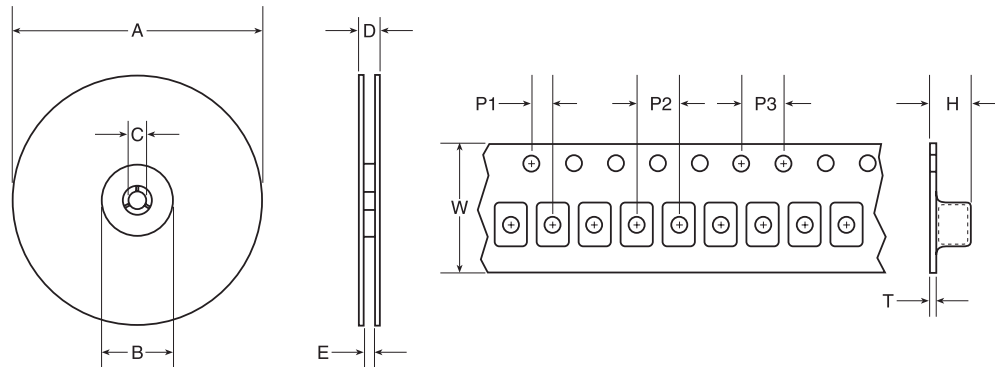
Item	Reference documents	Test Condition	Test Specification
1. High Temperature Exposure	MIL-STD-202 Method 108	1. Temperature: +125/155°C 2. Time: 1000 hours	1. No mechanical and electrical damage 2. Inductance shall not change more than $\pm 30\%$
2. Temperature Cycling	JESD22 Method JA-104	1. Temperature: -55/40°C~125/155°C 2. Number of cycles: 1000 cycle 3. Dwell time: 30 minutes	1. No mechanical and electrical damage 2. Inductance shall not change more than $\pm 30\%$
3. Biased Humidity Test	MIL-STD-202 Method 103	1. Temperature: 85 ± 5 °C 2. Time: 1000 hours 3. Humidity: 85 $\pm 5\%$ RH	1. No mechanical and electrical damage 2. Inductance shall not change more than $\pm 30\%$
4. Operational Life	MIL-PRF-27	1. Temperature: 125 / 155°C 2. Time: 1000 hours 3. Apply rated current	1. No mechanical and electrical damage 2. Inductance shall not change more than $\pm 30\%$
5. External Visual	MIL-STD-883 Method 2009	Inspect product construction, marking and workmanship	Per product specification standard
6. Physical Dimensions	JESD22 Method JB-100	Verify physical dimensions to the applicable product detail specification	Per product specification standard
7. Resistance to solvents	MIL-STD-202 Method 215	Immerse into solvent for 3 ± 0.5 minutes & brush 10 times for their cycles.	1. No body change in appearance 2. No marking blurred. 3. Inductance shall not change more than $\pm 30\%$
8. Vibration Test	MIL-STD-202 Method 204	1. Frequency and Amplified: 10-2000-10 Hz, 1.5mm 2. Direction: X, Y, Z 3. Test duration: 2 hours for each direction, 6 hours in total	1. No mechanical and electrical damage 2. Inductance shall not change more than $\pm 30\%$
9. Resistance to Soldering Heat Test	MIL-STD-202 Method 210	1. Temperature: 250 ± 5 °C 2. Time: (temp. ≥ 217 °C) 92-109 Second 3. IR reflow times: 3 times	1. No mechanical and electrical damage 2. Inductance shall not change more than $\pm 30\%$
10. Rated Current	MIL-STD-202 Method 330	Apply rated current for 5 seconds.	1. No mechanical and electrical damage 2. Inductance shall not change more than $\pm 30\%$
11. Temperature Rise	MIL-PRF-27	Apply rated current for 10 minutes.	1. No mechanical and electrical damage 2. Inductance shall not change more than $\pm 30\%$
12. Over load	MIL-PRF-27	Apply twice as rated current for 5 minutes.	1. No mechanical and electrical damage 2. Inductance shall not change more than $\pm 30\%$
13. Solderability Test	J-STD-002	1. Baking in pre-testing: 155 ± 5 °C / 16Hours ± 30 min. 2. Peak temperature: 245°C 3. Time: (temp. ≥ 217 °C) 112 Second 4. IR reflow times: 1 time	The terminal shall be at least 95% covered with fresh solder.
14. Electrical Characterization	User Spec.	1. Operating temperature: -55/40°C~125/155°C 2. Room Temperature: 25°C	1. No mechanical and electrical damage 2. Inductance shall not change more than $\pm 30\%$
15. Withstanding Voltage Test	MIL-STD-202 Method 201	1. DV: 500V 2. Time: 1 minute	1. During the test no breakdown. 2. The characteristic is normal after test.
16. Drop	JESD22-B111	Package & Drop down from 1m. In 1 angle 1 ridge & 2 surfaces orientation	1. No case deformation or change in appearance. 2. Inductance shall not change more than $\pm 30\%$
17. Terminal Strength Test	JIS-C-6429	1. Apply push force to samples mounted on PCB. 2. Force of 1.8 kg for 60 ± 1 seconds.	After test, inductors shall be on mechanical damage.

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Tape and Reel Specifications



Series	Parts per Reel	Reel Dimensions (mm)					Tape Dimensions (mm)					
		A	B	C	D	E	W	P1	P2	P3	H	T
1210 ACC	2000	178	60	13.5	12	9	8	2	4	4	2.5	0.26
1812 ACC	500	178	60	13	17	14	12	2	8	4	4	0.35

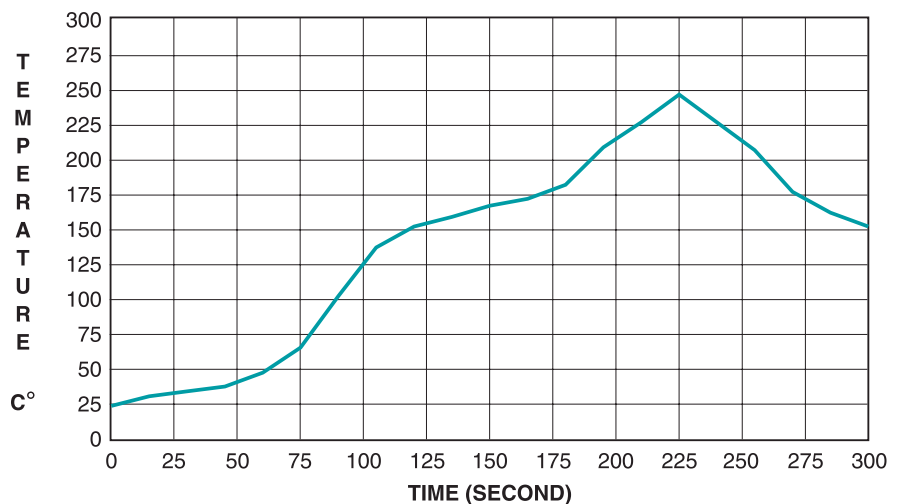
III. Description:

- a. Ferrite drum core construction
- b. Magnetically shielded
- c. Enameled copper wire: H class
- d. Product weight: 0.15g (ref.)
- e. Moisture sensitivity Level 1
- f. Products comply with RoHS' requirements
- g. Halogen Free available

IV. General specification:

- a. Storage temp: -40°C to +125°C
- b. Operating temp: -40°C to +125°C
(Temp. rise included)
- c. Resistance to solder heat: 250°C 10 secs.

Recommended Solder Heat Resistance Profile



For More Information

Pulse Worldwide Headquarters

15255 Innovation Drive,
Suite 100
San Diego,
CA, 92128
U.S.A.

Tel: 858 674 8100
Fax: 858 674 8262

Pulse Europe

Humboldtstrasse 32
Leinfelden-Echterdingen
D-70771
Germany

Tel: 49 7032 78060
Fax: 49 7032 7806 135

Pulse China - Shenzhen

B708, Shenzhen Academy
of Aerospace
Technology Bldg.
The 10th Keji South Road
Nanshan District
Shenzhen, PR China
518057

Tel: 86 755 33966678
Fax: 86 755 33966700

Pulse South China

1F, No.111, Xiyuan Road
Zhongli District
Taoyuan City 32057
Taiwan (R.O.C)

Tel: 886 3 4356768
Fax: 886 3 4356820

Pulse Asia

3 Fraser Street
0428 DUO Tower
Singapore 189352

Tel: 65 6287 8998
Fax: 65 6280 0080

Pulse India

No.14, 5th Main Rd.
Ground Floor, Opp to
Cha Cha Park,
Jauamahal Extension,
Bangalore-560 046,
India

Tel: 91 95990 31171

Pulse Japan

Yebisu Garden
Place Tower 23F
4-20-3 Ebisu,
Shibuya-Ku
Tokyo 150-6023
Japan

Tel: 81 3 5792 9760

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